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# Proof of the VC Bound

In this Appendix, we present the formal proof of Theorem 2.5. It is a fairly elaborate proof, and you may skip it altogether and just take the theorem for granted, but you won't know what you are missing ③!

Theorem A.1 (Vapnik, Chervonenkis, 1971).

$$\mathbb{P}\left[\sup_{h\in\mathcal{H}}|\mathcal{E}_{\mathrm{in}}(h)-\mathcal{E}_{\mathrm{out}}(h)| > \epsilon\right] \leq 4m\mu(2N)e^{-\frac{1}{8}\epsilon^2N}.$$

This inequality is called the VC Inequality, and it implies the VC bound of Theorem 2.5. The inequality is valid for any target function (deterministic or probabilistic) and any input distribution. The probability is over data set is generated iid (independent and identically distributed), with each data point generated independently according to the joint distribution  $P(\mathbf{x},y)$ . The event  $\sup_{h \in \mathcal{H}} |E_{\mathrm{in}}(h) - E_{\mathrm{out}}(h)| > \epsilon$  is equivalent to the union over all  $h \in \mathcal{H}$  of the events  $|E_{\mathrm{in}}(h) - E_{\mathrm{out}}(h)| > \epsilon$ ; this union contains the event that involves g in Theorem 2.5. The use of the supremum (a contains the event that involves g in Theorem 2.5. The use of the supremum (a fechnical version of the maximum) is necessary since  $\mathcal{H}$  can have a continuum for the continuum form of the continuum form of the maximum) is necessary since  $\mathcal{H}$  can have a continuum form of the continu

Of hypotheses. The main challenge to proving this theorem is that  $\mathbb{E}_{out}(h)$  is difficult to manipulate compared to  $\mathbb{E}_{in}(h)$ , because  $\mathbb{E}_{out}(h)$  depends on the entire input space rather than just a finite set of points. The main insight needed to overcome this difficulty is the observation that we can get rid of  $\mathbb{E}_{out}(h)$  altogether deviations between  $\mathbb{E}_{in}$  and  $\mathbb{E}_{out}$  can be essentially captured by deviations between two in-sample errors:  $\mathbb{E}_{in}$  (the original in-sample error) and the in-sample error on a second independent data set (Lemma A.2). We have seen this idea many times before when we use a test or validation set to estimate  $\mathbb{E}_{out}$ . This insight results in two main simplifications:

I. The supremum of the deviations over infinitely many  $h \in \mathcal{H}$  can be reduced to considering only the dichotomies implementable by  $\mathcal{H}$  on the

there is nothing to prove. Proof. We can assume that  $\mathbb{P}\left[\sup_{h\in\mathcal{H}}|\mathcal{E}_{\mathrm{in}}(h)-\mathcal{E}_{\mathrm{out}}(h)|>\epsilon\right]>0$ , otherwise

$$\left[ \frac{1}{2} \left| \operatorname{Cout}(h) - \operatorname{E}_{\operatorname{in}}(h) \right| + \frac{1}{2} \operatorname{Cout}(h) - \operatorname{E}_{\operatorname{in}}(h) = \frac{1}{2} \operatorname{Cout}(h) - \operatorname{E}_{\operatorname{out}}(h) - \operatorname{E}_{\operatorname{out}}(h)$$

 $\mathcal{B}_1$ ,  $\mathcal{B}_2$ . Now, let's consider the last term: Inequality (A.1) follows because  $\mathbb{P}[\mathcal{B}_1] \leq \mathbb{P}[\mathcal{B}_1 \text{ and } \mathcal{B}_2]$  for any two events

$$\mathbb{E}\left[\frac{1}{2} \left| \mathcal{E}_{\mathrm{in}}^{\mathrm{in}}(h) - \mathcal{E}_{\mathrm{in}}^{\mathrm{in}}(h) \right| > \frac{1}{2} \left| \frac{1}{2} \right| \operatorname{sup}_{\mathrm{in}}(h) - \mathcal{E}_{\mathrm{out}}(h) > \epsilon\right] \right] = \frac{1}{2}$$

depend on D', but it does depend on D. is in the event on which we are conditioning. The hypothesis  $h^st$  does not which  $|E_{\text{in}}(h^*) - E_{\text{out}}(h^*)| > \epsilon$ . One such hypothesis must exist given that  $\mathcal{D}$ probability. Fix a data set  $\mathcal D$  in this event. Let  $h^*$  be any hypothesis for The event on which we are conditioning is a set of data sets with non-zero

$$\mathbb{P}\left[\sup_{h \in \mathcal{H}} |\mathcal{E}_{in}(h^*) - \mathcal{E}_{in}(h^*)| > \frac{\epsilon}{2} \left| \sup_{h \in \mathcal{H}} |\mathcal{E}_{in}(h) - \mathcal{E}_{out}(h)| > \epsilon \right] \right]$$

$$(S.A) \qquad \left[\sup_{h \in \mathcal{H}} |\mathcal{E}_{in}(h^*) - \mathcal{E}_{in}(h^*)| > \frac{\epsilon}{2} \left| \sup_{h \in \mathcal{H}} |\mathcal{E}_{in}(h) - \mathcal{E}_{out}(h)| > \epsilon \right] \right]$$

$$(S.A) \qquad \left[ |\mathcal{E}_{in}(h^*) - \mathcal{E}_{in}(h^*)| > \frac{\epsilon}{2} \left| \sup_{h \in \mathcal{H}} |\mathcal{E}_{in}(h) - \mathcal{E}_{out}(h)| > \epsilon \right]$$

$$(S.A) \qquad \left[ |\mathcal{E}_{in}(h^*) - \mathcal{E}_{in}(h^*)| > \frac{\epsilon}{2} \left| \sup_{h \in \mathcal{H}} |\mathcal{E}_{in}(h)| > \epsilon \right|$$

$$\geq \mathbb{P}\left[|E_{in}'(h^*) - E_{out}(h^*)| \leq \frac{\epsilon}{2} \left| \sup_{h \in \mathcal{H}} |E_{in}(h) - E_{out}(h)| \right| > \epsilon\right]$$

1. Inequality (A.2) follows because the event "
$$|E_{in}(h^*) - E'_{in}(h^*)| > \frac{\epsilon}{2}$$
" implies "sup  $|E_{in}(h) - E'_{in}(h)| > \frac{\epsilon}{2}$ ".

and " $|E_{\text{in}}(h^*) - E_{\text{out}}(h^*)| > \epsilon$ " (which is given) imply " $|E_{\text{in}}(h) - E_{\text{in}}(h)| > \epsilon$ " 2. Inequality (A.3) follows because the events " $|E_{\rm in}^i(h^*) - E_{\rm out}(h^*)| \leq \frac{2}{5}$ "

can apply the Hoeffding Inequality to  $\mathbb{P}[|E_i^{in}(h^*) - E_{out}(h^*)| \leq \frac{\epsilon}{2}]$ . 3. Inequality (A.4) follows because  $h^*$  is fixed with respect to  $\mathcal{D}'$  and so we

for any  $h^*$ , as long as  $h^*$  is fixed with respect to  $\mathcal{D}'$ . Therefore, it also applies Notice that the Hoeffding Inequality applies to  $\mathbb{P}[|E_{in}^i(h^*) - E_{out}(h^*)| \leq \frac{\epsilon}{2}]$ 

> enters the picture (Lemma A.3). two independent data sets. That is where the growth function  $m_{\mathcal{H}}(2N)$

alyze compared to the deviation between  $E_{\rm in}$  and  $E_{\rm out}$  (Lemma A.4). 2. The deviation between two independent in-sample errors is 'easy' to an-

The combination of Lemmas A.2, A.3 and A.4 proves Theorem A.1.

#### Deviations A.1 Relating Generalization Error to In-Sample

 $\mathbb{P}[|E_{in} - E_{in}^{\prime}| \text{ is large}], \text{ which is easier to analyze.}$ analysis. We hope to bound the term  $\mathbb{P}[|E_{in} - E_{out}| \text{ is large}]$  by another term ghost data set because it doesn't really exist; it is a just a tool used in the according to the same distribution  $P(\mathbf{x},y)$ . This second data set is called a Let's introduce a second data set  $\mathcal{D}'$ , which is independent of  $\mathcal{D}$ , but sampled

is also large. Therefore,  $\mathbb{P}[|E_{\text{in}}(h) - E_{\text{out}}(h)|$  is large] can be approximately is, when  $|E_{in}(h) - E_{out}(h)|$  is large, with a high probability  $|E_{in}(h) - E_{out}(h)|$ Inequality guarantees that  $E_{\text{in}}(h) \approx E_{\text{out}}(h)$  with a high probability. That esis h, because  $\mathcal{V}$  is fresh, sampled independently from  $P(\mathbf{x}, y)$ , the Hoeffding The intuition behind the formal proof is as follows. For any single hypoth-

We are trying to bound the probabilportuged by  $\mathbb{P}[|\mathcal{L}_{in}(h) - \mathcal{L}_{in}(h)|$  is large].

red region represents the cases when  $E_{\rm in}$ illustrated in the figure to the right. The bility is roughly Gaussian around Eout, as distributed). When N is large, the probaspility, since Ein and Ein are identically is far from  $E_{out}$ , with that same probwith some probability (and similarly Ein on  $\mathcal{D}'$ . Suppose that  $E_{\mathrm{in}}$  is far from  $E_{\mathrm{out}}$ be the 'in-sample' error for hypothesis h ity that  $E_{\rm in}$  is far from  $E_{\rm out}$ . Let  $E'_{\rm in}(h)$ 

approximately bounded by  $2 \mathbb{P} [|E_{in} - E_{in}]$  is large]. as illustrated by the green region. That is,  $\mathbb{P}[|E_{in} - E_{out}| \text{ is large}]$  can be is far from Lout. In those cases, Lin is far from Lin about half the time,

ment can be carefully extended to multiple hypotheses. sud Eout can be captured by the deviations between Ein and Ein. The argu-This argument provides some intuition that the deviations between Ein

$$\left(\mathbb{I} - 2e^{-\frac{1}{2}e^{2}N}\right) \mathbb{E} \left[\sup_{x \in \mathbb{N}} |\mathcal{E}_{\text{in}}(h) - \mathcal{E}_{\text{out}}(h)| > \epsilon\right] \leq \mathbb{E} \left[\sup_{x \in \mathbb{N}} |\mathcal{E}_{\text{in}}(h)| - \mathcal{E}_{\text{in}}(h)| > \epsilon\right]$$

where the probability on the RHS is over  $\mathcal{D}$  and  $\mathcal{D}'$  jointly.

Let  $\mathcal{H}(S)$  be the dichotomies that  $\mathcal{H}$  can implement on the points in S. By definition of the growth function,  $\mathcal{H}(S)$  cannot have more than  $m_{\mathcal{H}}(2N)$  di-chotomies. Suppose it has  $M \leq m_{\mathcal{H}}(2N)$  dichotomies, realized by  $h_1, \ldots, h_M$ .

$$\text{Thus,} \sup_{h \in \mathcal{H}} |\mathcal{E}_{\text{in}}(h) - \mathcal{E}_{\text{in}}'(h)| = \sup_{h \in \{h_1, \dots, h_M\}} |\mathcal{E}_{\text{in}}(h) - \mathcal{E}_{\text{in}}'(h)|.$$

треп,

$$(3.A) \qquad \begin{bmatrix} S \mid \frac{\delta}{2} < |(h_{ni}^{\dagger}H - (h_{ni}^{\dagger}H - (h_{ni}^{$$

$$(6.A) \qquad \lim_{m \to 1} \mathbb{E}\left[|E_{\text{in}}(h) - E_{\text{in}}'(h)| > \frac{\epsilon}{2} \mid S\right], \qquad (6.6)$$

where we use the union bound in (A.5), and overestimate each term by the supremum over all possible hypotheses to get (A.6). After using  $M \le m_{\mathcal{H}}(2N)$  and taking the sup operation over S, we have proved:

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$$|\mathcal{L}| = \lim_{h \to \infty} |\mathcal{L}| = \lim_$$

where the probability on the LHS is over  $\mathcal D$  and  $\mathcal D'$  jointly, and the probability on the RHS is over random partitions of S into two sets  $\mathcal D$  and  $\mathcal D'$ .

The main achievement of Lemma A.3 is that we have pulled the supremum over  $h \in \mathcal{H}$  outside the probability, at the expense of the extra factor

### A.3 Bounding the Devistion between In-Sample

We now address the purely combinatorial problem of bounding

$$\sup_{x \in \mathcal{H}} \mathbb{P}\left[|E_{\mathrm{in}}(h) - E_{\mathrm{in}}(h)| > \frac{\varepsilon}{2}\right],$$

which appears in Lemma A.3. We will prove the following lemma. Then, Theorem A.1 can be proved by combining Lemmas-A.2, A.3 and A.4 taking  $1-2e^{-\frac{1}{2}\epsilon^2 N} \geq \frac{1}{2}$  (the only case we need to consider).

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to any weighted average of  $\mathbb{P}[|E_{\text{in}}^*(h^*) - E_{\text{out}}(h^*)| \leq \frac{\epsilon}{2}]$  based on  $h^*$ . Finally, since  $h^*$  depends on a particular  $\mathcal{D}$ , we take the weighted average over all  $\mathcal{D}$  in the event

$$\lim_{y \to \infty} |\mathcal{F}_{in}(h) - \mathcal{E}_{out}(h)| > \epsilon^n$$

on which we are conditioning, where the weight comes from the probability of the particular  $\mathcal{D}$ . Since the bound holds for every  $\mathcal{D}$  in this event, it holds for the weighted average.

Note that we can assume  $e^{-\frac{1}{2}\epsilon^2N} < \frac{1}{4}$ , because otherwise the bound in Theorem A.1 is trivially true. In this case,  $1 - 2e^{-\frac{1}{2}\epsilon^2N} > \frac{1}{2}$ , so the lemma impulses

$$\mathbb{E}\left[\sup_{t \in \mathcal{U}} |E_{\text{in}}(h) - E_{\text{out}}(h)| > \epsilon\right] \leq 2 \mathbb{E}\left[\sup_{t \in \mathcal{U}} |E_{\text{in}}(h) - E_{\text{in}}(h)| > \frac{\epsilon}{2}\right].$$

### A.2 Bounding Worst Case Deviation Using the Growth Function

Now that we have related the generalization error to the deviations between in-sample errors, we can actually work with  $\mathcal H$  restricted to two data sets of size N each, rather than the infinite  $\mathcal H$ . Specifically, we want to bound

$$\lim_{T \to \infty} \left| \frac{1}{\zeta} \right| = \lim_{T \to \infty} (\eta) = \lim_{T \to \infty} (\eta) = \lim_{T \to \infty} \frac{1}{\zeta}$$

where the probability is over the joint distribution of the data sets  $\mathcal{D}$  and  $\mathcal{D}'$ . One equivalent way of sampling two data sets  $\mathcal{D}$  and  $\mathcal{D}'$  is to first sample a data set S of size SN, then randomly partition S into  $\mathcal{D}$  and  $\mathcal{D}'$ . This amounts to randomly sampling, without replacement, N examples from S for  $\mathcal{D}$ , leaving the remaining for  $\mathcal{D}'$ . Given the joint data set S, let

$$\mathbb{E}\left[S \middle| \mathcal{E}_{i}^{\eta} < |(\eta)^{\mathrm{ui}} \mathcal{H} - \mathcal{E}_{i}^{\eta}(\eta)| > \frac{\varepsilon}{2}\right] \mathbb{E}\left[S \middle| \mathcal{E}_{i}^{\eta}(\eta)| > \frac{\varepsilon}{2}\right]$$

be the probability of deviation between the two in-sample errors, where the probability is taken over the random partitions of S into D and D'. By the law of total probability (with  $\sum$  denoting sum or integral as the case may be),

$$\left[ S \middle| \frac{\zeta}{2} < |(y)^{ui} \mathcal{J} - (y)^{ui} \mathcal{J} | \frac{\mathcal{H}^{3} y}{\mathrm{dns}} \right] \mathbb{J} \quad \text{dns} \quad >$$

$$\left[ S \middle| \frac{\zeta}{2} < |(y)^{ui} \mathcal{J} - (y)^{ui} \mathcal{J} | \frac{\mathcal{H}^{3} y}{\mathrm{dns}} \right] \mathbb{J} \times [S] \mathbb{J} \quad =$$

$$\left[ \frac{\zeta}{2} < |(y)^{ui} \mathcal{J} - (y)^{ui} \mathcal{J} | \frac{\mathcal{H}^{3} y}{\mathrm{dns}} \right] \mathbb{J} \quad \text{dns}$$

Lemma A.4. For any h and any S,

$$\mathbb{P}\left[|E_{\mathrm{in}}(h)-E_{\mathrm{i}}(h)|>\frac{\epsilon}{2}\left|S\right|\leq 2\epsilon^{-\frac{1}{8}\epsilon^{2}N},\right.$$

where the probability is over random partitions of S into two sets  $\mathcal D$  and  $\mathcal D'$ .

Proof. To prove the result, we will use a result, which is also due to Hoeffding,

for sampling without replacement:

**Lemma A.5** (Hoeffding, 1963). Let  $\mathcal{A} = \{a_1, \dots, a_{2N}\}$  be a set of values with  $a_n \in [0, 1]$ , and let  $\mu = \frac{1}{2N} \sum_{n=1}^{2N} a_n$  be their mean. Let  $\mathcal{D} = \{z_1, \dots, z_N\}$  be a sample of size N, sampled from A uniformly without replacement. Then

$$\int_{N_{\varepsilon}^{3}} \left[ \frac{1}{2} \sum_{n} \left[ \frac{1}{2} \left[ \frac{1}{2} \sum_{n} \left[ \frac{1}{2} \sum_{n} \frac{N}{2} \right] \right] \right] dt$$

We apply Lemma A.5 as follows. For the 2N examples in S, let  $a_n = 1$  if  $h(\mathbf{x}_n) \neq y_n$  and  $a_n = 0$  otherwise. The  $\{a_n\}$  are the errors made by h on S. Now randomly partition S into  $\mathcal{D}$  and  $\mathcal{D}'$ , i.e., sample N examples from S without replacement to get  $\mathcal{D}$ , leaving the remaining N examples for  $\mathcal{D}'$ . This results in a sample of size N of the  $\{a_n\}$  for  $\mathcal{D}$ , sampled uniformly without replacement. Note that

$$E_{\text{in}}(h) = \frac{N}{1} \sum_{a_n \in \mathcal{D}} a_n$$
, and  $E_{\text{in}}(h) = \frac{N}{1} \sum_{a'_n \in \mathcal{D}_n} a'_n$ .

Since we are sampling without replacement,  $S = \mathcal{D} \cup \mathcal{D}'$  and  $\mathcal{D} \cap \mathcal{D}' = \emptyset$ , and

$$h = \frac{2N}{1} \sum_{N=1}^{\infty} a_N = \frac{1}{E_{in}(h) + E_{in}(h)}.$$

It follows that  $|E_{in} - \mu| > t \iff |E_{in} - E'_{in}| > 2t$ . By Lemma A.5,

$$\mathbb{P}\left[|E_{\mathrm{in}}(h)-E_{\mathrm{in}}(h)|>2t\right]\leq 2e^{-2t^2N}.$$

Substituting  $t = \frac{\epsilon}{4}$  gives the result.